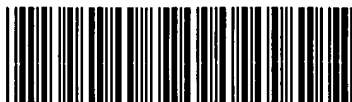


Search Notes

Application/Control No.

10/679,290

Examiner

Alex Liew

Applicant(s)/Patent under
Reexamination

SHISHIDO ET AL.

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
382/141-152,154 limited to text search	3/7/2007	AL